

Notice of References Cited		Application/Control No. 10/538,727	Applicant(s)/Patent Under Reexamination SHITE, HIDEO	
		Examiner YEWEBDAR T. TADESCSE	Art Unit 1792	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,527,860	03-2003	Yoshihara et al.	118/50
	B	US-			
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	D	US-			
	E	US-			
	F	US-			
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FOREIGN PATENT DOCUMENTS

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NON-PATENT DOCUMENTS

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